


<b>Search Notes</b> 	<b>Application/Control No.</b> 10823400	<b>Applicant(s)/Patent Under Reexamination</b> BAUER ET AL.
	<b>Examiner</b> Tae H Yoon	<b>Art Unit</b> 1796

SEARCHED			
Class	Subclass	Date	Examiner
524	437	2/16/2008	/TY/
ATD		10/24/09	/TY/

SEARCH NOTES			
Search Notes		Date	Examiner
EAST		2/16 and 2/18/2008	/TY/
EAST		9/13/08	/TY/
EAST		2/12/09	/TY/

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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